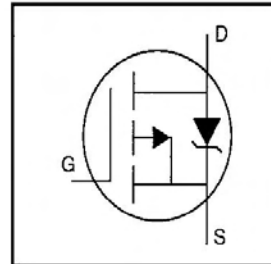


# IRFI9Z24GPbF

HEXFET® Power MOSFET

- Isolated Package
- High Voltage Isolation= 2.5KVRMS Ⓢ
- Sink to Lead Creepage Dist.= 4.8mm
- P-Channel
- 175°C Operating Temperature
- Dynamic dv/dt Rating
- Low Thermal Resistance
- Lead-Free

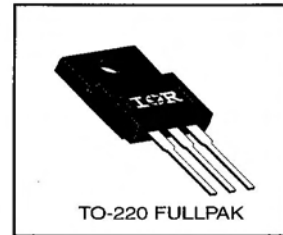


$V_{DSS} = -60V$
$R_{DS(on)} = 0.28\Omega$
$I_D = -8.5A$

**Description**

Third Generation HEXFETs from International Rectifier provide the designer with the best combination of fast switching, ruggedized device design, low on-resistance and cost-effectiveness.

The TO-220 Fullpak eliminates the need for additional insulating hardware in commercial-industrial applications. The moulding compound used provides a high isolation capability and a low thermal resistance between the tab and external heatsink. This isolation is equivalent to using a 100 micron mica barrier with standard TO-220 product. The Fullpak is mounted to a heatsink using a single clip or by a single screw fixing.



**Absolute Maximum Ratings**

	Parameter	Max.	Units
$I_D @ T_C = 25^\circ C$	Continuous Drain Current, $V_{GS} @ -10 V$	-8.5	A
$I_D @ T_C = 100^\circ C$	Continuous Drain Current, $V_{GS} @ -10 V$	-6.0	
$I_{DM}$	Pulsed Drain Current ①	-34	
$P_D @ T_C = 25^\circ C$	Power Dissipation	37	W
	Linear Derating Factor	0.24	W/°C
$V_{GS}$	Gate-to-Source Voltage	$\pm 20$	V
$E_{AS}$	Single Pulse Avalanche Energy ②	200	mJ
$I_{AR}$	Avalanche Current ①	-8.5	A
$E_{AR}$	Repetitive Avalanche Energy ①	3.7	mJ
dv/dt	Peak Diode Recovery dv/dt ③	-4.5	V/ns
$T_J$ $T_{STG}$	Operating Junction and Storage Temperature Range	-55 to +175	°C
	Soldering Temperature, for 10 seconds	300 (1.6mm from case)	
	Mounting Torque, 6-32 or M3 screw	10 lbf•in (1.1 N•m)	

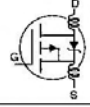
**Thermal Resistance**

	Parameter	Min.	Typ.	Max.	Units
$R_{\theta JC}$	Junction-to-Case	—	—	4.1	°C/W
$R_{\theta JA}$	Junction-to-Ambient	—	—	65	

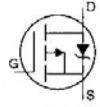
# IRFI9Z24GPbF

International  
IR Rectifier

## Electrical Characteristics @ $T_J = 25^\circ\text{C}$ (unless otherwise specified)

	Parameter	Min.	Typ.	Max.	Units	Test Conditions
$V_{(BR)DSS}$	Drain-to-Source Breakdown Voltage	-60	—	—	V	$V_{GS}=0V, I_D=-250\mu A$
$\Delta V_{(BR)DSS}/\Delta T_J$	Breakdown Voltage Temp. Coefficient	—	-0.056	—	V/°C	Reference to $25^\circ\text{C}$ , $I_D=-1mA$
$R_{DS(on)}$	Static Drain-to-Source On-Resistance	—	—	0.28	$\Omega$	$V_{GS}=-10V, I_D=-5.1A$ ④
$V_{GS(th)}$	Gate Threshold Voltage	-2.0	—	-4.0	V	$V_{DS}=V_{GS}, I_D=-250\mu A$
$g_{fs}$	Forward Transconductance	3.2	—	—	S	$V_{DS}=-25V, I_D=-5.1A$ ④
$I_{DSS}$	Drain-to-Source Leakage Current	—	—	-100	$\mu A$	$V_{DS}=-60V, V_{GS}=0V$
		—	—	-500		$V_{DS}=-48V, V_{GS}=0V, T_J=150^\circ\text{C}$
$I_{GSS}$	Gate-to-Source Forward Leakage	—	—	-100	nA	$V_{GS}=-20V$
	Gate-to-Source Reverse Leakage	—	—	100		$V_{GS}=20V$
$Q_g$	Total Gate Charge	—	—	19	nC	$I_D=-11A$
$Q_{gs}$	Gate-to-Source Charge	—	—	5.4		$V_{DS}=-48V$
$Q_{gd}$	Gate-to-Drain ("Miller") Charge	—	—	11		$V_{GS}=-10V$ See Fig. 6 and 13 ④
$t_{d(on)}$	Turn-On Delay Time	—	13	—	ns	$V_{DD}=-30V$
$t_r$	Rise Time	—	68	—		$I_D=-11A$
$t_{d(off)}$	Turn-Off Delay Time	—	15	—		$R_G=18\Omega$
$t_f$	Fall Time	—	29	—		$R_D=2.5\Omega$ See Figure 10 ④
$L_D$	Internal Drain Inductance	—	4.5	—	nH	Between lead, 6 mm (0.25in.) from package and center of die contact 
$L_S$	Internal Source Inductance	—	7.5	—		
$C_{iss}$	Input Capacitance	—	570	—	pF	$V_{GS}=0V$
$C_{oss}$	Output Capacitance	—	360	—		$V_{DS}=-25V$
$C_{rbs}$	Reverse Transfer Capacitance	—	65	—		$f=1.0MHz$ See Figure 5
C	Drain to Sink Capacitance	—	12	—		$f=1.0MHz$

## Source-Drain Ratings and Characteristics

	Parameter	Min.	Typ.	Max.	Units	Test Conditions
$I_S$	Continuous Source Current (Body Diode)	—	—	-8.5	A	MOSFET symbol showing the integral reverse p-n junction diode. 
$I_{SM}$	Pulsed Source Current (Body Diode) ①	—	—	-34		
$V_{SD}$	Diode Forward Voltage	—	—	-6.3	V	$T_J=25^\circ\text{C}, I_S=-8.5A, V_{GS}=0V$ ④
$t_{rr}$	Reverse Recovery Time	—	100	200	ns	$T_J=25^\circ\text{C}, I_F=-11A$
$Q_{rr}$	Reverse Recovery Charge	—	0.32	0.64	$\mu C$	$di/dt=100A/\mu s$ ④
$t_{on}$	Forward Turn-On Time	Intrinsic turn-on time is negligible (turn-on is dominated by $L_S+L_D$ )				

### Notes:

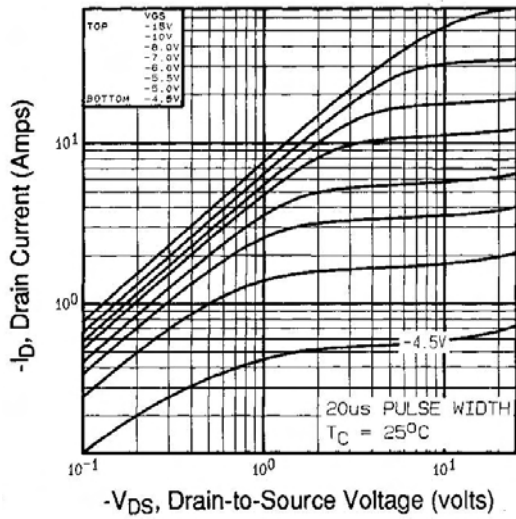
① Repetitive rating; pulse width limited by max. junction temperature (See Figure 11)

③  $I_{SD} \leq -11A, di/dt \leq 140A/\mu s, V_{DD} \leq V_{(BR)DSS}, T_J \leq 175^\circ\text{C}$

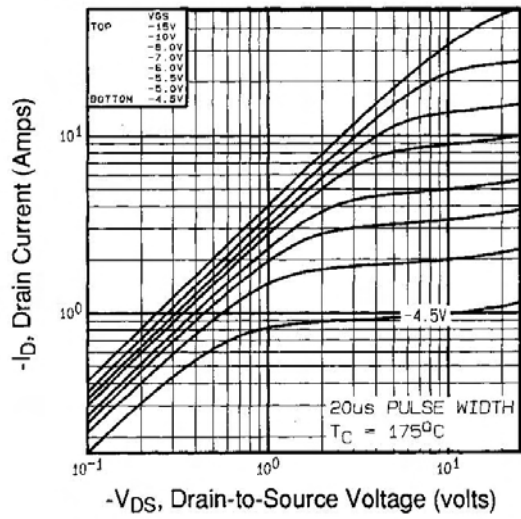
⑤  $t=60s, f=60Hz$

②  $V_{DD}=-25V$ , starting  $T_J=25^\circ\text{C}$ ,  $L=3.2mH$   
 $R_G=25\Omega, I_{AS}=-8.5A$  (See Figure 12)

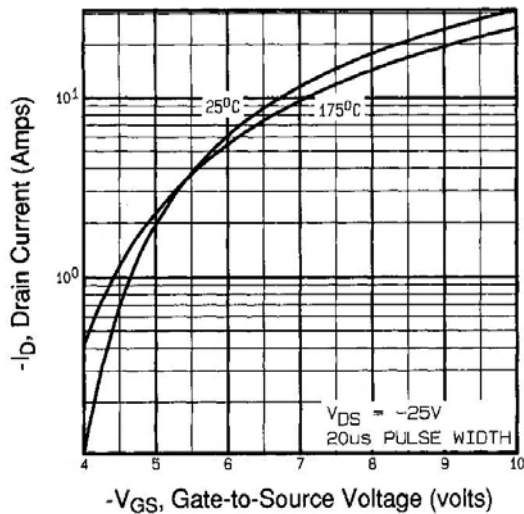
④ Pulse width  $\leq 300 \mu s$ ; duty cycle  $\leq 2\%$ .



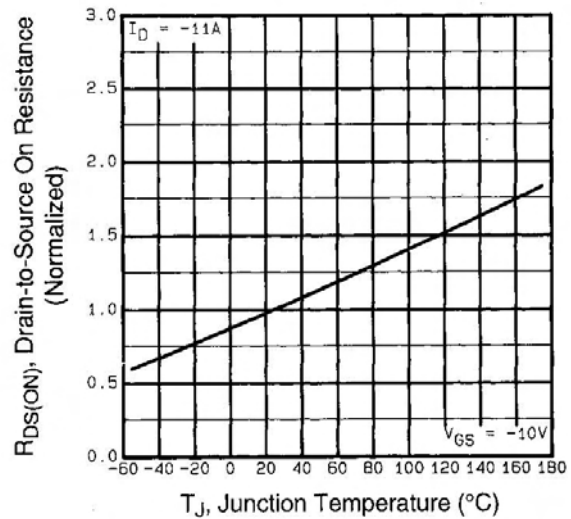
**Fig 1.** Typical Output Characteristics,  
 $T_C = 25^\circ\text{C}$



**Fig 2.** Typical Output Characteristics,  
 $T_C = 175^\circ\text{C}$

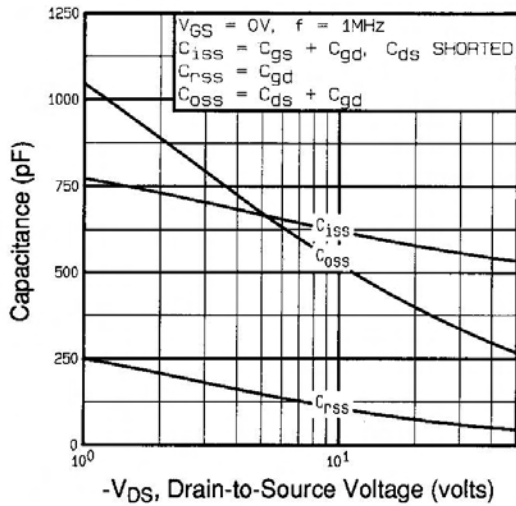


**Fig 3.** Typical Transfer Characteristics

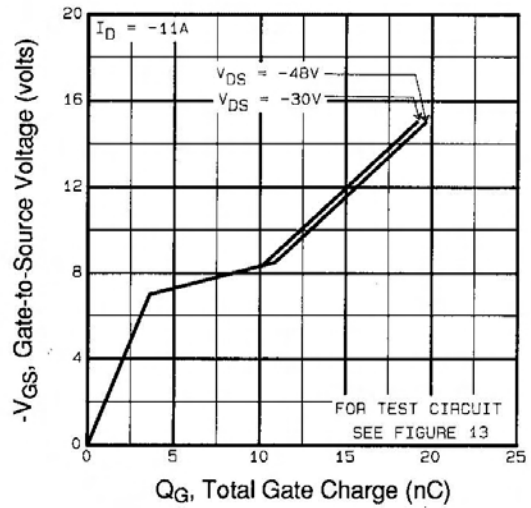


**Fig 4.** Normalized On-Resistance  
Vs. Temperature

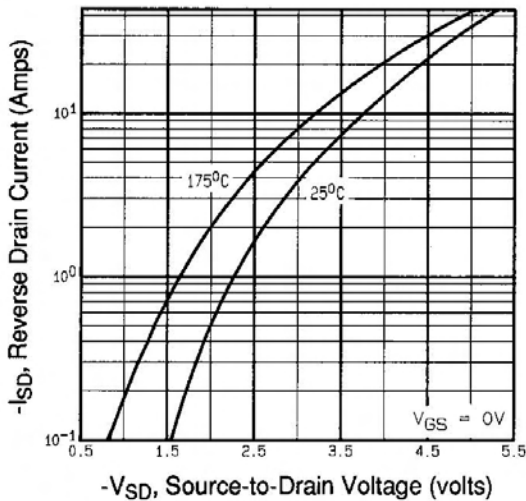
# IRFI9Z24GPbF



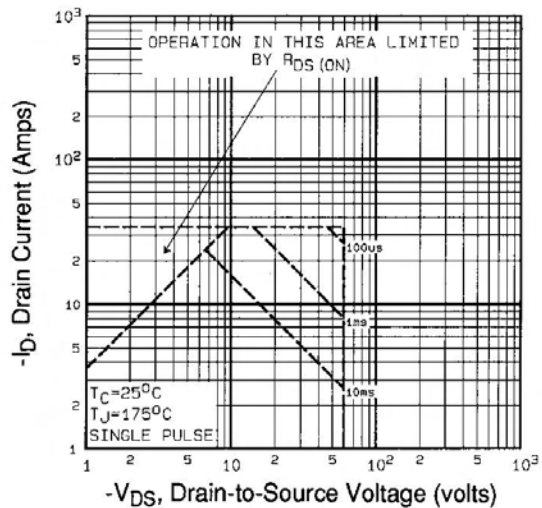
**Fig 5.** Typical Capacitance Vs. Drain-to-Source Voltage



**Fig 6.** Typical Gate Charge Vs. Gate-to-Source Voltage

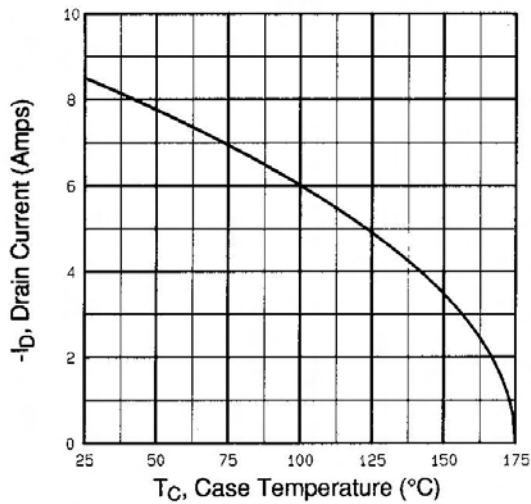


**Fig 7.** Typical Source-Drain Diode Forward Voltage

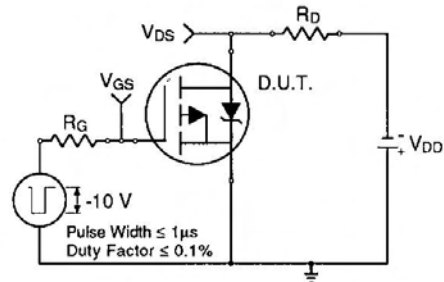


**Fig 8.** Maximum Safe Operating Area

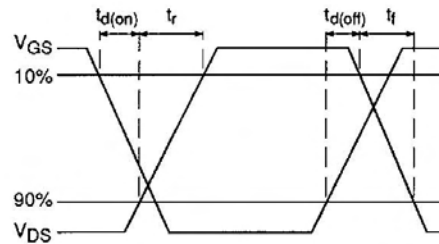




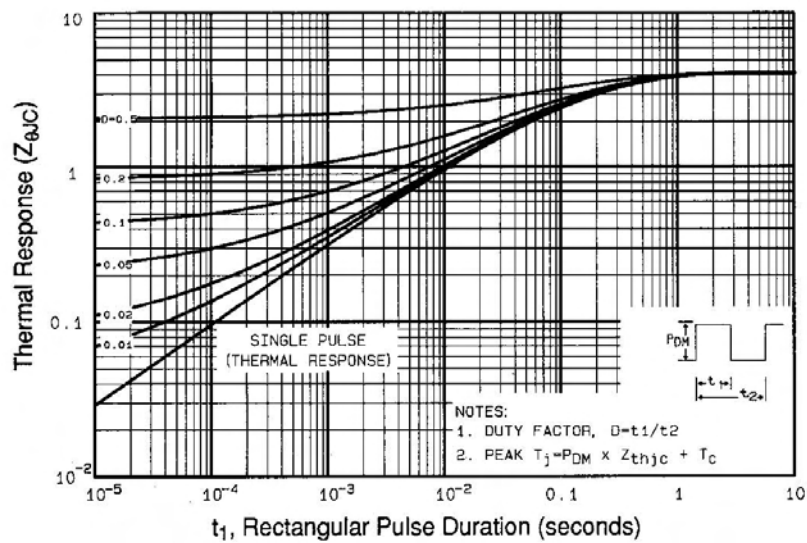
**Fig 9.** Maximum Drain Current Vs. Case Temperature



**Fig 10a.** Switching Time Test Circuit



**Fig 10b.** Switching Time Waveforms



**Fig 11.** Maximum Effective Transient Thermal Impedance, Junction-to-Case

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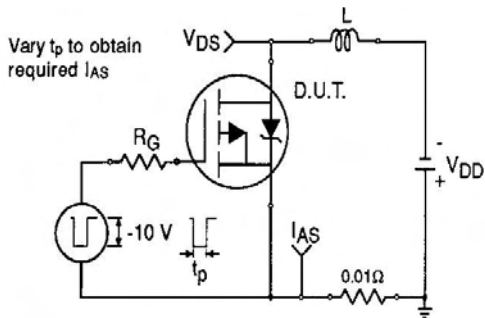


Fig 12a. Unclamped Inductive Test Circuit

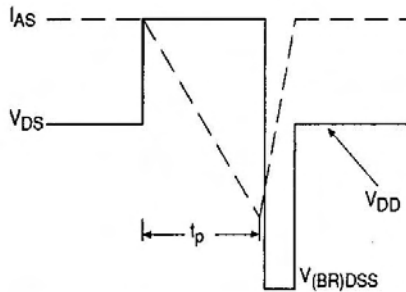


Fig 12b. Unclamped Inductive Waveforms

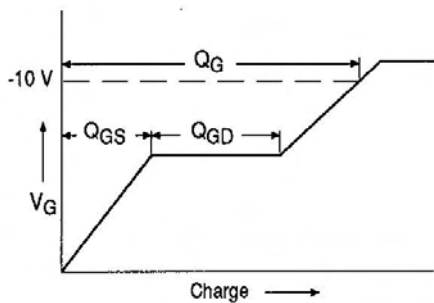


Fig 13a. Basic Gate Charge Waveform

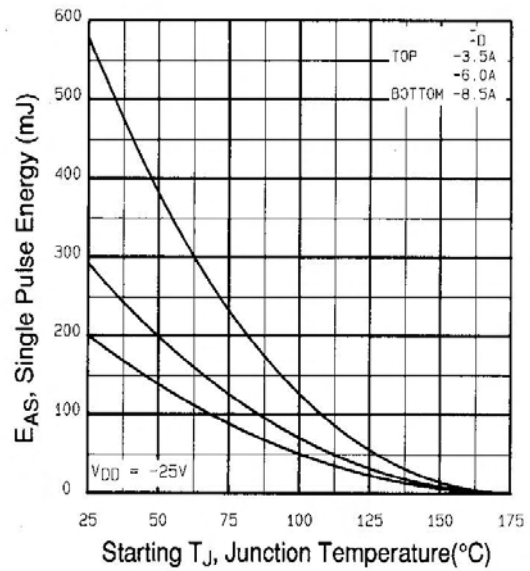


Fig 12c. Maximum Avalanche Energy Vs. Drain Current

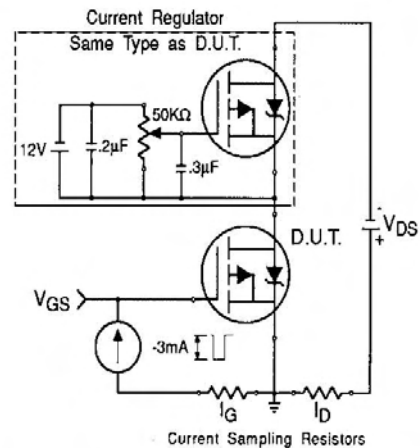
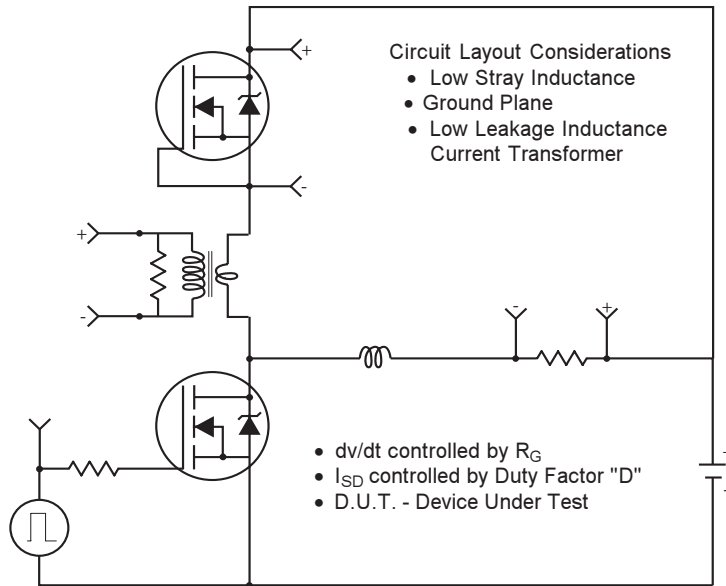


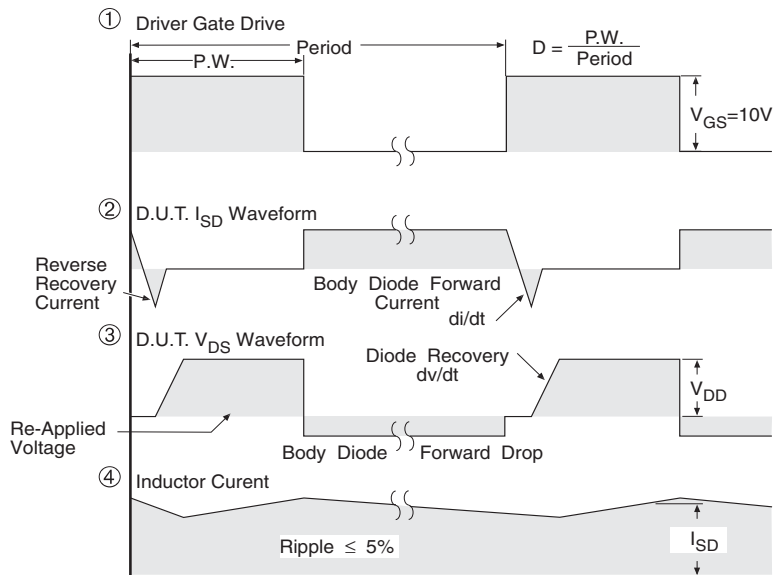
Fig 13b. Gate Charge Test Circuit

## Peak Diode Recovery dv/dt Test Circuit



\* Reverse Polarity for P-Channel

\*\* Use P-Channel Driver for P-Channel Measurements



\*\*\*  $V_{GS} = 5.0V$  for Logic Level and 3V Drive Devices

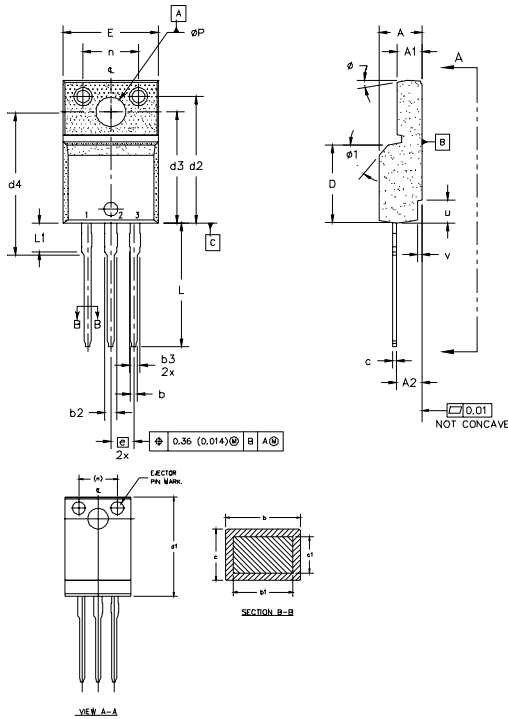
**Fig 14** For P Channel HEXFETS

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## TO-220 Full-Pak Package Outline

Dimensions are shown in millimeters (inches)



**NOTES:**

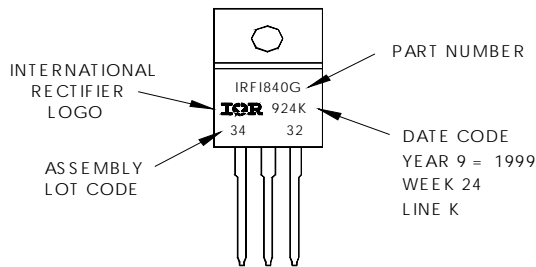
- 1.0 DIMENSIONING AND TOLERANCING PER ASME Y14.5 M- 1994.
- 2.0 DIMENSIONS ARE SHOWN IN MILLIMETERS [INCHES].
- 3.0 LEAD DIMENSION AND FINISH UNCONTROLLED IN L1.
- 4.0 DIMENSION D & E DO NOT INCLUDE MOLD FLASH. MOLD FLASH SHALL NOT EXCEED 0.005" (0.127) PER SIDE. THESE DIMENSIONS ARE MEASURED AT THE OUTERMOST EXTREMES OF THE PLASTIC BODY.
- 5.0 DIMENSION b1 APPLY TO BASE METAL ONLY.
- 6.0 STEP OPTIONAL ON PLASTIC BODY DEFINED BY DIMENSIONS u & v.
- 7.0 CONTROLLING DIMENSION : INCHES.

SYMBOL	DIMENSIONS				NOTES	LEAD ASSIGNMENTS
	MILLIMETERS		INCHES			
	MIN.	MAX.	MIN.	MAX.		
A	4.57	4.83	0.180	0.190		
A1	2.57	2.83	0.101	0.114		
A2	2.51	2.85	0.099	0.112		
b	0.622	0.89	0.024	0.035	5	HEXFET 1.- GATE 2.- DRAIN 3.- SOURCE
b1	0.622	0.838	0.024	0.033		
b2	1.229	1.400	0.048	0.055		
b3	1.229	1.400	0.048	0.055		
c	0.440	0.629	0.017	0.025		
c1	0.440	0.584	0.017	0.023	4	IGBTs, CoPACK 1.- GATE 2.- COLLECTOR 3.- EMITTER
D	8.65	9.80	0.341	0.386		
d1	15.80	16.12	0.622	0.635		
d2	13.97	14.22	0.550	0.560		
d3	12.30	12.92	0.484	0.509		
d4	8.64	9.91	0.340	0.390	4	
E	10.36	10.63	0.408	0.419		
e	2.54 BSC		0.100 BSC			
L	13.20	13.73	0.520	0.541	3	
L1	3.10	3.50	0.122	0.138		
n	6.05	6.15	0.238	0.242		
phi P	3.05	3.45	0.120	0.136		
u	2.40	2.50	0.094	0.098	6	
v	0.40	0.50	0.016	0.020	6	
phi	3"	7"	3"	7"		
phi1		45"		45"		

## TO-220 Full-Pak Part Marking Information

EXAMPLE: THIS IS AN IRFI840G  
WITH ASSEMBLY  
LOT CODE 3432  
ASSEMBLED ON WW 24 1999  
IN THE ASSEMBLY LINE "K"

**Note:** "P" in assembly line position indicates "Lead-Free"



Data and specifications subject to change without notice.



IR WORLD HEADQUARTERS: 233 Kansas St., El Segundo, California 90245, USA Tel: (310) 252-7105  
TAC Fax: (310) 252-7903  
12/04





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